## Notice of References Cited Application/Control No. 10/016,740 Examiner Aaron Strange Applicant(s)/Patent Under Reexamination KIME ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0123659	07-2003	Forstrom et al.	380/205
	В	US-2003/0084179	05-2003	Kime et al.	709/231
	С	US-2002/0138736	09-2002	Morin, Marc	713/180
	D	US-2002/0023169	02-2002	Ponzio, Frank J. JR.	709/232
	E	US-2001/0051928	12-2001	Brody, Moshe	705/52
	F	US-6,738,815	05-2004	Willis et al.	709/225
	G	US-6,606,393	08-2003	Xie et al.	382/100
	Н	US-6,546,113	04-2003	Lucas et al.	382/100
	ı	US-6,480,961	11-2002	Rajasekharan et al.	713/200
	J	US-6,173,406	01-2001	Wang et al.	713/201
	К	US-6,065,119	05-2000	Sandford et al.	713/200
	L	US-6,073,124	06-2000	Krishnan et al.	705/59
	М	US-5,958,051	09-1999	Renaud et al.	713/200

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				·	
	Р					
	Ø					
	Ŕ					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.